## N tic of R f rences Cit d Application/Control No. 09/849,460 Examiner Victor Yevsikov Applicant(s)/Patent Under Reexamination YANG ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,451,658	09-2002	Akram et al.	438/299
	В	US-			
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	D	US-			
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	F	US-			
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